

<b>Notice of References Cited</b>	Application/Control No. 10/759,006	Applicant(s)/Patent Under Reexamination NAGAHASHI ET AL.	
	Examiner Jonathan Liou	Art Unit 2672	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,236,389	05-2001	Imaizumi et al.	715/788
	B	US-6,229,566	05-2001	Matsumoto et al.	348/231.2
	C	US-6,184,860	02-2001	Yamakawa, Tadashi	715/823
	D	US-6,128,013	10-2000	Prabhu et al.	715/707
	E	US-6,111,586	08-2000	Ikeda et al.	345/619
	F	US-5,901,253	05-1999	Tretter, Daniel R.	382/289
	G	US-5,805,132	09-1998	Imaizumi et al.	345/418
	H	US-5,430,832	07-1995	Imaizumi et al.	345/620
	I	US-6,169,544	01-2001	Onoda, Hitoshi	715/723
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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